

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10520169	BACON ET AL.
<b>Examiner</b>	<b>Art Unit</b>	
Shin-Lin Chen	1632	

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
West, updated.	3-18-08	sic
West updated.	9-25-08	sic
Updated.	3-2-09	sic

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

	/Shin-Lin Chen/ Primary Examiner.Alt Unit 1632
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